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LCE30ND07S

LCE N-Channel Super Junction Power MOSFET

### Description

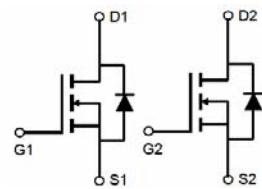
The LCE30ND07S uses advanced trench technology and design to provide excellent  $R_{DS(ON)}$  with low gate charge. It can be used in a wide variety of applications.

### General Features

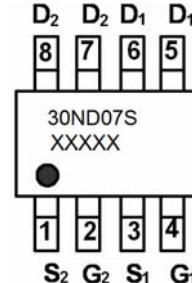
- $V_{DS} = 30V, I_D = 7A$
- $R_{DS(ON)} < 23m\Omega @ V_{GS}=10V$
- $R_{DS(ON)} < 40m\Omega @ V_{GS}=4.5V$
- High density cell design for ultra low  $R_{DS(on)}$
- Fully characterized avalanche voltage and current

### Application

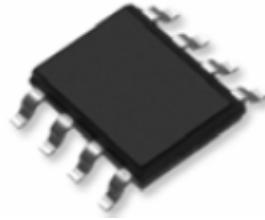
- Power switching application
- Hard switched and high frequency circuits
- Uninterruptible power supply



Schematic diagram



Marking and pin Assignment



SOP-8 top view

### Package Marking and Ordering Information

Device Marking	Device	Device Package	Reel Size	Tape width	Quantity
30ND07S	LCE30ND07S	SOP-8	Ø330mm	12mm	2500 units

### Absolute Maximum Ratings ( $T_A=25^\circ C$ unless otherwise noted)

Parameter	Symbol	Limit	Unit
Drain-Source Voltage	$V_{DS}$	30	V
Gate-Source Voltage	$V_{GS}$	$\pm 20$	V
Drain Current-Continuous	$I_D$	7	A
Drain Current-Continuous( $T_C=100^\circ C$ )	$I_D (100^\circ C)$	4.95	A
Pulsed Drain Current	$I_{DM}$	40	A
Maximum Power Dissipation	$P_D$	2	W
Operating Junction and Storage Temperature Range	$T_J, T_{STG}$	-55 To 150	°C

### Thermal Characteristic

Parameter	Symbol	Typ	Max	Unit
Thermal Resistance, Junction-to-Ambient (Note 2)	$R_{\theta JA}$	62.5	85	°C/W



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### Electrical Characteristics ( $T_A=25^\circ\text{C}$ unless otherwise noted)

Parameter	Symbol	Condition	Min	Typ	Max	Unit
<b>Off Characteristics</b>						
Drain-Source Breakdown Voltage	$\text{BV}_{\text{DSS}}$	$V_{\text{GS}}=0\text{V}, I_{\text{D}}=250\mu\text{A}$	30	-	-	V
Zero Gate Voltage Drain Current	$I_{\text{DSS}}$	$V_{\text{DS}}=30\text{V}, V_{\text{GS}}=0\text{V}$	-	-	1	$\mu\text{A}$
Gate-Body Leakage Current	$I_{\text{GSS}}$	$V_{\text{GS}}=\pm 20\text{V}, V_{\text{DS}}=0\text{V}$	-	-	$\pm 100$	nA
<b>On Characteristics</b> (Note 3)						
Gate Threshold Voltage	$V_{\text{GS}(\text{th})}$	$V_{\text{DS}}=V_{\text{GS}}, I_{\text{D}}=250\mu\text{A}$	1.1	-	2.1	V
Drain-Source On-State Resistance	$R_{\text{DS}(\text{ON})}$	$V_{\text{GS}}=10\text{V}, I_{\text{D}}=7\text{A}$	-	18	23	$\text{m}\Omega$
		$V_{\text{GS}}=4.5\text{V}, I_{\text{D}}=6\text{A}$	-	25	40	
Forward Transconductance	$g_{\text{FS}}$	$V_{\text{DS}}=5\text{V}, I_{\text{D}}=7\text{A}$	-	15	-	S
<b>Dynamic Characteristics</b> (Note 4)						
Input Capacitance	$C_{\text{iss}}$	$V_{\text{DS}}=15\text{V}, V_{\text{GS}}=0\text{V}, F=1.0\text{MHz}$	-	380	-	PF
Output Capacitance	$C_{\text{oss}}$		-	67	-	PF
Reverse Transfer Capacitance	$C_{\text{rss}}$		-	41	-	PF
<b>Switching Characteristics</b> (Note 4)						
Turn-on Delay Time	$t_{\text{d}(\text{on})}$	$V_{\text{DD}}=15\text{V}, R_{\text{L}}=2\Omega$ $V_{\text{GS}}=10\text{V}, R_{\text{G}}=3\Omega$	-	5	-	nS
Turn-on Rise Time	$t_{\text{r}}$		-	3	-	nS
Turn-Off Delay Time	$t_{\text{d}(\text{off})}$		-	15	-	nS
Turn-Off Fall Time	$t_{\text{f}}$		-	3	-	nS
Total Gate Charge	$Q_{\text{g}}$	$V_{\text{DS}}=15\text{V}, I_{\text{D}}=7\text{A}, V_{\text{GS}}=4.5\text{V}$	-	7.2	-	nC
Gate-Source Charge	$Q_{\text{gs}}$		-	1.3	-	nC
Gate-Drain Charge	$Q_{\text{gd}}$		-	1.7	-	nC
<b>Drain-Source Diode Characteristics</b>						
Diode Forward Voltage (Note 3)	$V_{\text{SD}}$	$V_{\text{GS}}=0\text{V}, I_{\text{S}}=7\text{A}$	-	-	1.2	V
Diode Forward Current (Note 2)	$I_{\text{S}}$		-	-	7	A

### Notes:

1. Repetitive Rating: Pulse width limited by maximum junction temperature.
2. The value of  $R_{\text{SDA}}$  is measured with the device mounted on 1in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with  $T_A=25^\circ\text{C}$ . The value in any given application depends on the user's specific board design. Surface Mounted on FR4 Board,  $t \leq 10$  sec. The current rating is based on the  $t \leq 10$ s thermal resistance rating.
3. Pulse Test: Pulse Width  $\leq 300\mu\text{s}$ , Duty Cycle  $\leq 2\%$ .
4. Guaranteed by design, not subject to production.

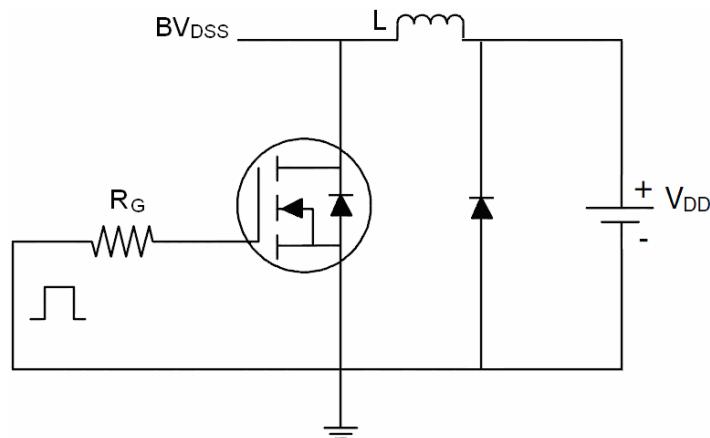


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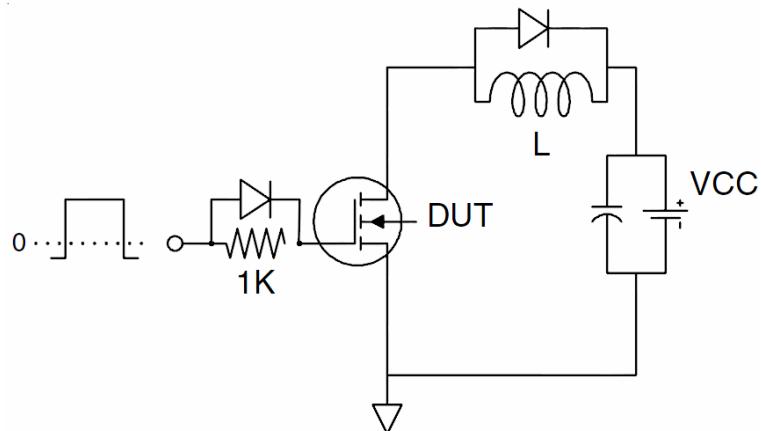
LCE30ND07S

## Test Circuit

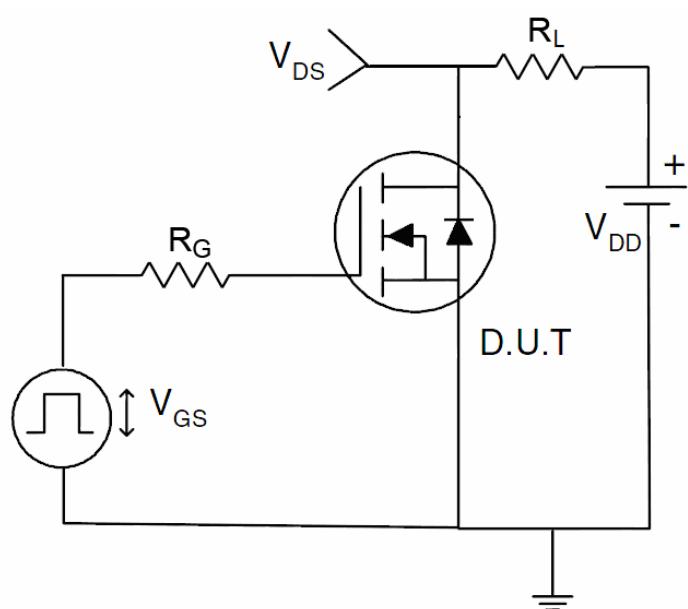
### 1) E<sub>AS</sub> Test Circuits



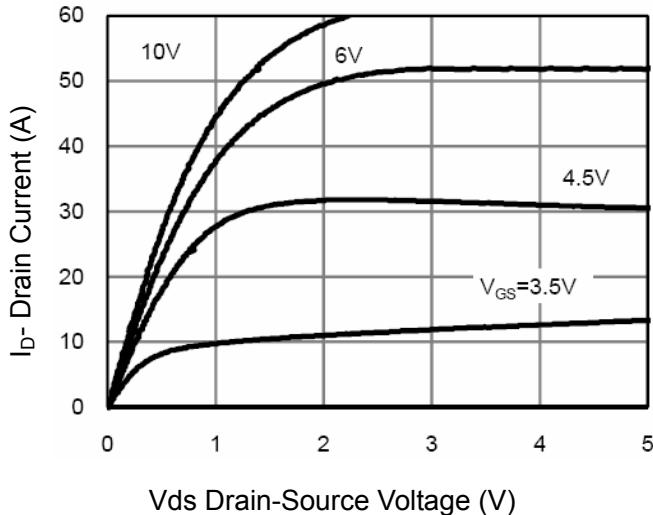
### 2) Gate Charge Test Circuit:



### 3) Switch Time Test Circuit:

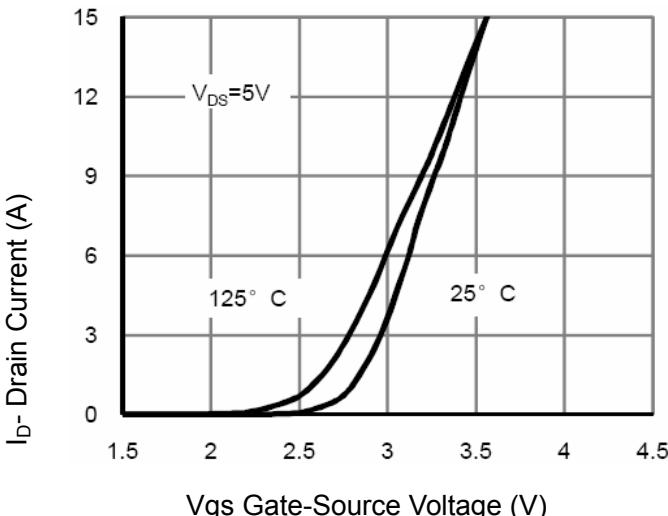


### Typical Electrical and Thermal Characteristics (Curves)



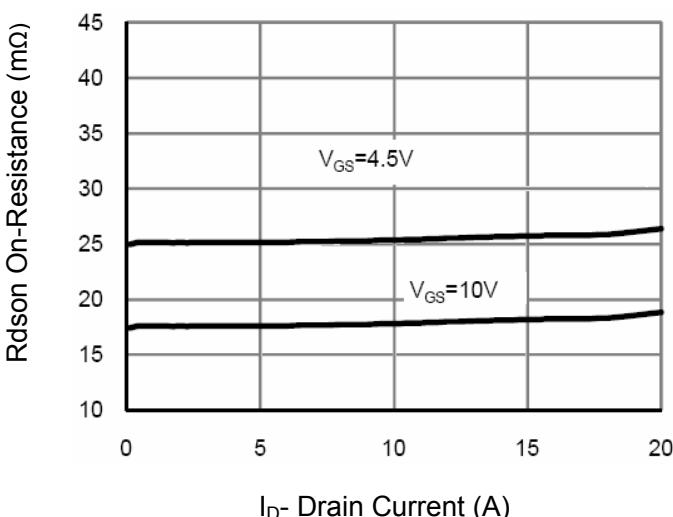
V<sub>DS</sub> Drain-Source Voltage (V)

**Figure 1 Output Characteristics**



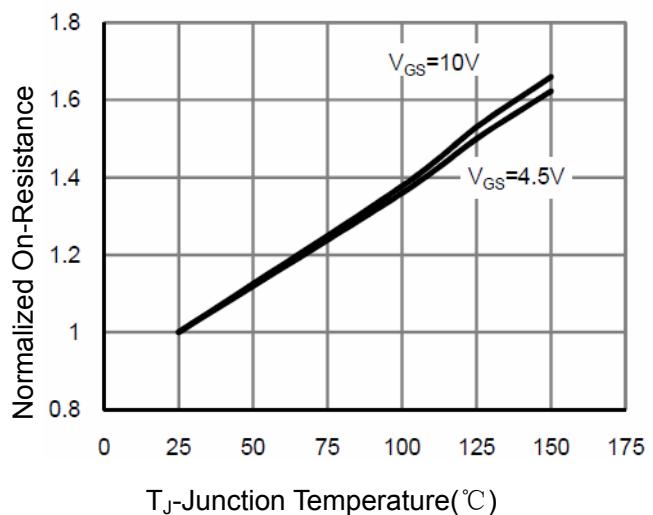
V<sub>GS</sub> Gate-Source Voltage (V)

**Figure 2 Transfer Characteristics**



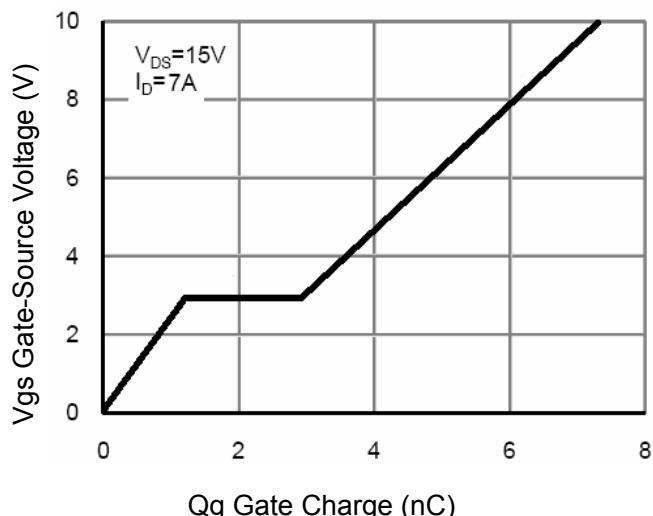
$I_D$  Drain Current (A)

**Figure 3 Rdson- Drain Current**



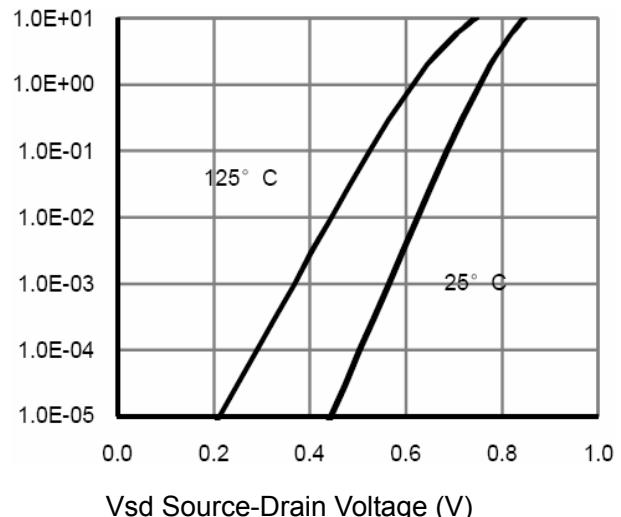
$T_J$  Junction Temperature (°C)

**Figure 4 Rdson-JunctionTemperature**



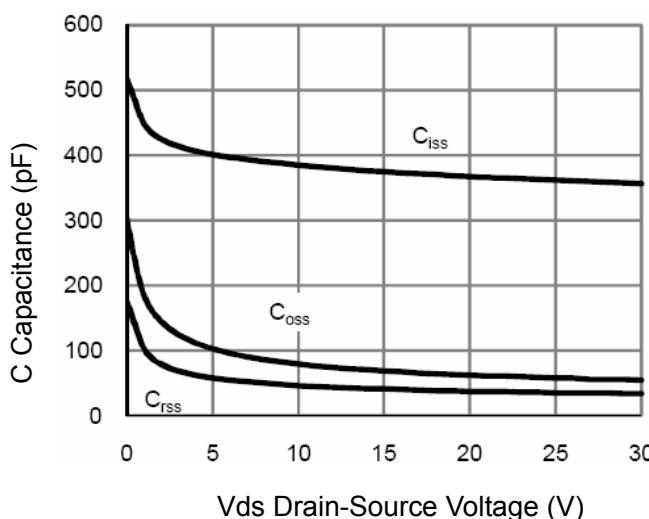
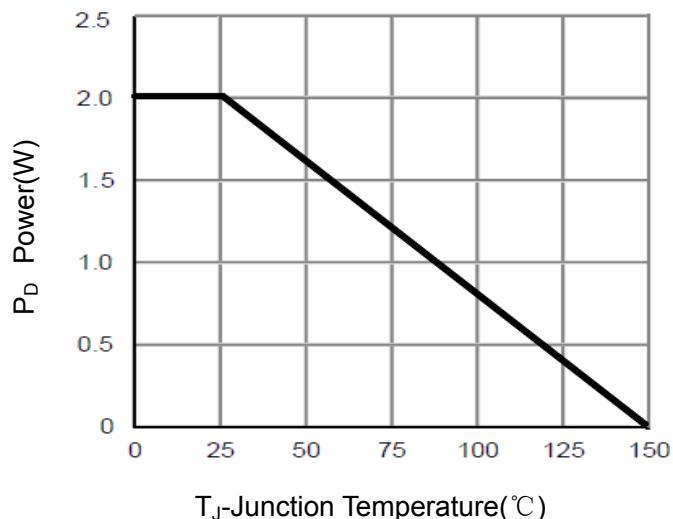
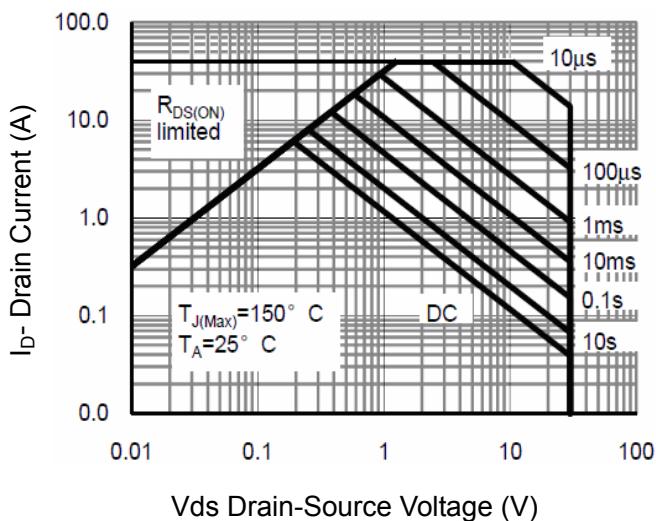
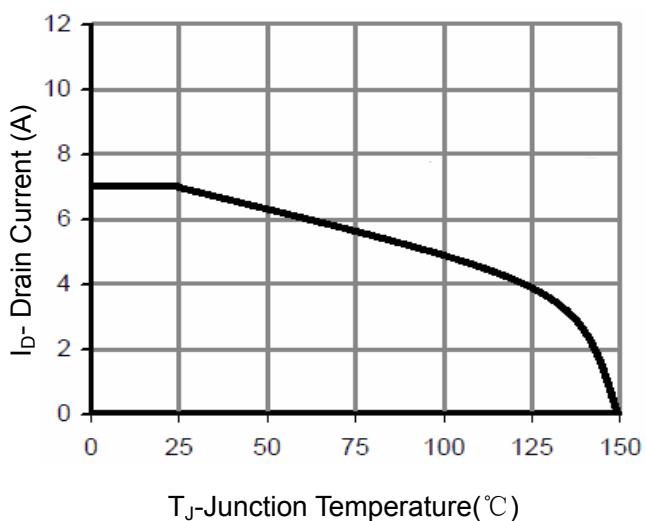
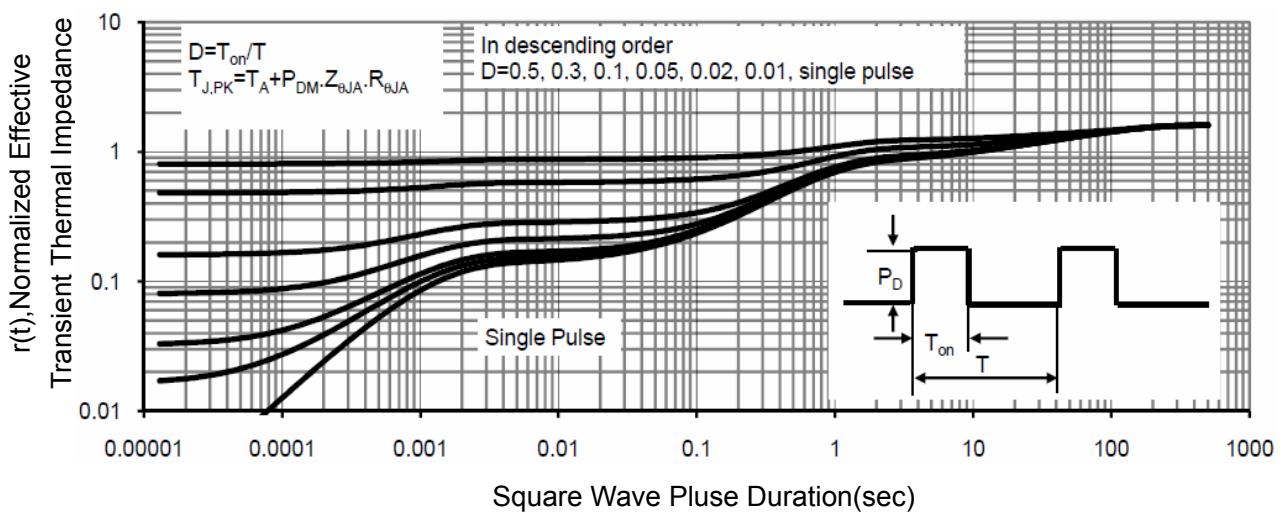
$V_{GS}$  Gate-Source Voltage (V)

**Figure 5 Gate Charge**



$V_{SD}$  Source-Drain Voltage (V)

**Figure 6 Source- Drain Diode Forward**

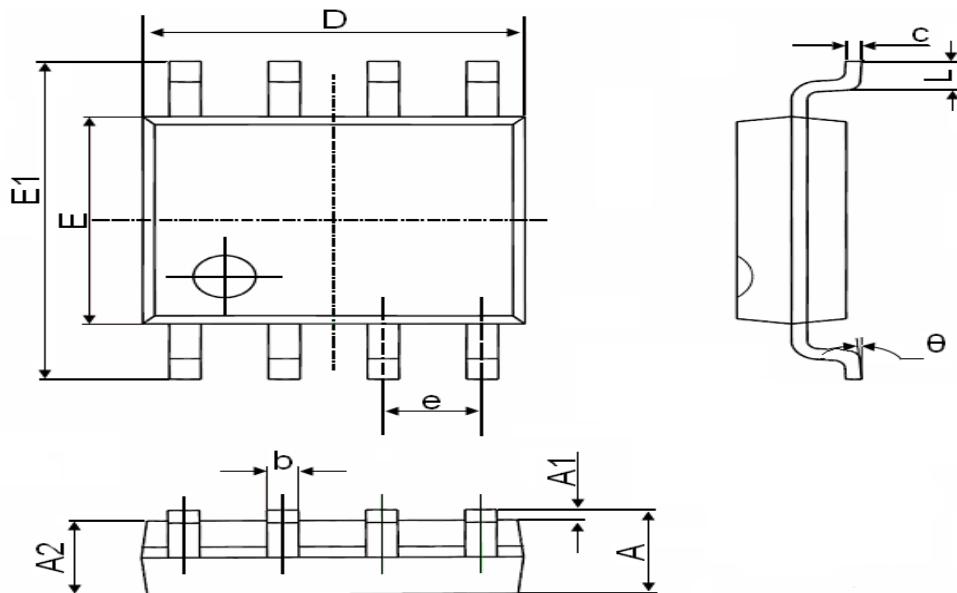

**Figure 7 Capacitance vs Vds**

**Figure 9 Power Dissipation**

**Figure 8 Safe Operation Area**

**Figure 10 Current De-rating**

**Figure 11 Normalized Maximum Transient Thermal Impedance**



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## SOP-8 Package Information



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min.	Max.	Min.	Max.
A	1.350	1.750	0.053	0.069
A1	0.100	0.250	0.004	0.010
A2	1.350	1.550	0.053	0.061
b	0.330	0.510	0.013	0.020
c	0.170	0.250	0.006	0.010
D	4.700	5.100	0.185	0.200
E	3.800	4.000	0.150	0.157
E1	5.800	6.200	0.228	0.244
e	1.270(BSC)		0.050(BSC)	
L	0.400	1.270	0.016	0.050
θ	0°	8°	0°	8°

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